Work-in-Progress: Determining MPSoC Layout from Thermal Camera Images

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ABSTRACT

In many safety-critical applications, Multi-Processor Systems-on-Chip (MPSoC) must operate within a given thermal envelope under harsh environmental conditions. Meeting the thermal requirements often requires using advanced task allocation and scheduling techniques that are guided by detailed power models. This paper introduces a method that has the potential to simplify the creation of such models. It constructs so-called heat maps from thermal camera images. By comparing the heat maps of different workloads, we identify the locations of on-chip components and the amount of heat produced by them. We demonstrate our method on the i.MX8QuadMax chip from NXP, where we identify the locations of CPU clusters, bigger CPU cores, GPUs, and DRAM controllers.

KEYWORDS

thermal camera, MPSoC, NXP i.MX8, heat map, thermal-aware

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ACM Reference Format:

1 INTRODUCTION

Thermal-aware design methods have become increasingly important in the development of embedded systems. In many applications, e.g., in future avionics systems, Multi-Processor Systems-on-Chip are needed for their high computing performance. However, at the same time, these MPSoCs must operate within a given thermal envelope under harsh environmental conditions. Meeting the stringent thermal requirements is often in contradiction with the high performance demands. For this reason, system designers look for methods that decrease the operating temperature while maintaining computational performance. The effectiveness of such methods often depends on the availability of accurate power models.

In this paper, we introduce an easily applicable method that has the potential to improve the quality of existing power models. It reveals interesting details about the MPSoC chip layout as well as the location and amount of heat generated by the given workload at different parts of the chip. The method is based on images from a thermal camera captured while running the workload. Compared to previously published works on a similar topic [2, 5], our method does not require mounting a special cooling device on the analyzed board. To demonstrate our method, we analyze the chip layout of NXP i.MX8QuadMax [3], which is an ARMv8 chip with six CPUs in big.LITTLE configuration (4× Cortex A53 and 2× Cortex A72) and 2 GPUs with a total of 16 shader processors with 64 execution units. This chip is not yet officially released by NXP, and little information about it is publicly available.

We publish the software for online image processing of the thermal images as open-source [4] to allow other researchers to analyze different chips and using the results in their work.

We believe that the obtained results will allow us to design better power models to guide various thermal-aware workload allocation and scheduling methods [1].

2 METHOD

The method to obtain the chip layout and the corresponding power density map is based on images from a thermal camera. We use a Workswell WIC camera with a spatial resolution of 336x256px, frame rate 9 Hz and thermal resolution 40 mK. The camera takes images of the board (see Fig. 1a). The location of the chip is marked with the red square whose edges are 20 mm long. We transform this area to a regular square of 100×100 pixels (see Fig. 1b). Then we use a method inspired by Zhang et al. [5]. By using a heat diffusion equation and considering only steady state, the spatial heat energy \( g_T \) generated at point \((x, y)\) is

\[
g_T(x, y) = -\kappa \nabla^2 T, \tag{1}
\]

where \(\kappa\) is thermal conductivity, \(\nabla^2\) is the Laplace operator, and \(T\) is the spatial temperature profile, i.e., Fig. 1b. Equation (1) allows determining the location of heat sources directly from the thermal camera image. As the image is noisy, we apply a Gaussian blur filter before calculating the Laplacian. Thermal conductivity \(\kappa\) can be determined as described in [5], but in this paper, we use \(\kappa = 100\) to avoid too small numbers in our graphs (Fig. 2). We are interested in determining the chip layout and not the exact amount of generated...
We applied our method to the Toradex Apalis i.MX8 board running Yocto Linux distribution. In the idle state (Fig. 1) only the necessary services were running (systemd, dbus, agetty, dropbear). The idle power consumption of the whole board was 5.2 W.

We run different workloads on our Themobench suite, collect the heat map \( g \) for each workload, and compare the heatmaps of different workloads by combining them to a single image – see Fig. 2. Each heatmap is drawn with a different hue; the intensity of the color is proportional to the amount of generated heat. The hues of different components are selected so that the combination of all used hues with the same intensity produces a shade of gray.

The location of main MPSoC components can be seen in Fig. 2a. The GPUs and the DRAM controllers could be clearly identified. The effect of dynamic voltage and frequency scaling (DVFS) for A72 cores can be seen in Fig. 2f. The CPU frequency influences the heat generation only at the location of the A72 cores and not at the other parts of the chip.

The chip layout presented in Fig. 2 matches pretty well the locations of the power supply pins in the SoC datasheet [3].

We performed the experiments both with and without the fan-induced airflow. The airflow prevents the chip from overheating during some experiments. The results \( g(x, y) \) do not depend on the presence of the airflow; the locations of chip components were the same in both cases.

### 4 CONCLUSION AND FUTURE WORK

We have described a method to obtain a so-called chip heat map from thermal camera images. This method does not require mounting any cooling devices used in similar works. Furthermore, software performing all necessary calculations in real-time is available as open-source [4]. We showed the applicability of our method on the NXP i.MX8QuadMax chip, whose complete documentation is not yet publicly released, and demonstrated that the location of some chip elements (CPU clusters, bigger CPU cores, GPUs, and DRAM controllers) could be clearly identified.

We plan to use the heat maps of various workloads to construct accurate per-workload power models. Using such models in thermal-aware task allocation and scheduling techniques should reduce the operating temperature, which is a vital property of many safety-critical embedded systems.

### ACKNOWLEDGMENTS

This research has received funding from the Clean Sky 2 Joint Undertaking under the European Union’s H2020 research and innovation programme under grant agreement No 832011 (THERMAC).

### REFERENCES


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